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CONFIRMATION NO. 9797

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RULE						
APPLICANTS Kazuyoshi Okawa, Nerima-ku, JAPAN; Junko Ogino, Nerima-ku, JAPAN; Masayuki Yoshinaga, Nerima-ku, JAPAN; Hajime Honda, Nerima-ku, JAPAN;						
** CONTINUING DATA ***** This application is a 371 of PCT/JP04/01805 02/18/2004						
** FOREIGN APPLICATIONS *****						
** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 04/10/2007						
Foreign Priority claimed	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input type="checkbox"/> Met after Allowance	STATE OR COUNTRY	SHEETS DRAWINGS	TOTAL CLAIMS	INDEPENDENT CLAIMS
35 USC 119(a-d) conditions met	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No		JAPAN	10	10	2
Verified and	/DANIEL F. MCMAHON/ Examiner's Signature		Initials			
Acknowledged						
ADDRESS Intellectual Property Law Office of David Lathrop No. 827 39120 Argonaut Way Fremont, CA 94538 UNITED STATES						
TITLE Semiconductor device test apparatus and method						
FILING FEE RECEIVED 900	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:			<input type="checkbox"/> All Fees		
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